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Application Number 10/082,397

Filing Date August 6, 2002

First Named Inventor: Mark W. Miles

Art Unit 2873

Examiner Name Mai, Huy Kim

Sheet 1 2 Attorney Docket Number 005652.P013XCD

			U.S. PA	TENT DOCUMENTS	<u>; </u>	
Examiner Cite No.¹		Document Number Number-Kind Code ² (If known)		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Hm		US-	4,900,395	2/13/90	Syverson et al.	
then		US-	5,293,272	3/8/94	Jannson et al.	
thm_		US-	5,358,601	10/25/94	Cathey	
f m		US-	5,726,480	3/10/98	Pister	
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FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No.1	Foreign Patent Document Country Code ³ Number Kind Code ³ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Т°	

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Sheet	2		of	2	Attorney Docket Number	005652.P013XCD		
,				NON PATENT LIT	ERATURE DOCUMENTS		-	
Examiner Initials*	Cite No ¹	Includ	le name of em (book, r	nagazine, journal, se	AL LETTERS), title of the article rial, symposium, catalog, etc.), (isher, city and/or country where	date, page(s), volume-issue	T²	
HM		IBBOT Physic	IBBOTSON, et al. "Comparison of XeF ₂ and F-atom reactions with Si and SiO ₂ ", Applied Physics Letters. Vol. 44, No. 12, June 1984. pp 1129-1131.					
fm		SCHN Confer 818.	CHNAKENBERG, et al. "Tmahw Etchants for Silicon Micromachining". 1991 International Conference on Solid State Sensors and Actuators - Digest of Technical Papers. pp. 815-18.					
HM		WILLI/ Microe	AMS, et a	I. "Etch Rates for M chanical Systems."	dicromachining Processing", Vol. 5 No. 4, December 1996	Journal of 6, pp 256-269.		
the .		WINTE No. 1,	ERS, et al Jan. 1979	., "The etching of s 9, pp. 70-73.	ilicon with XeF₂ vapor". Appli	ied Physics Letters, Vol. 34.		

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		Considered	

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